

**Search Notes**

Application/Control No.

10/663,575

Examiner

VanThu Nguyen

Applicant(s)/Patent under  
Reexamination

AGRAWAL ET AL.

Art Unit

2824

**SEARCHED**

Class	Subclass	Date	Examiner
365	191 193 x 194 x 202 x 203 x 233 x	2/1/2005	VTN
	233.5 o		
	241 x		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	2/1/2005	VTN